



PATENT APPLICATION

THE U.S. PATENT AND TRADEMARK OFFICE

August 23, 2007

Applicant: Hitoshi SATO et al

For: ROTATING MECHANISM OF BIAXIAL HINGE AND
PORTABLE TELEPHONE EQUIPPED WITH SAME

Serial No.: 10/549 538 Group: 2618

Confirmation No.: 3616

Filed: September 15, 2005 Examiner: Hannon

International Application No.: PCT/JP2004/015970

International Filing Date: October 21, 2004

Atty. Docket No.: 4700.P0316US

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

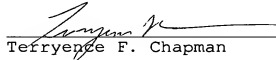
In compliance with the provisions of Rules 1.97(e)(1) and 1.98, enclosed herewith is a copy of a Japanese Office Action, Form PTO-1449 and the references cited thereon. Further comment at this point in time should not be necessary.

I hereby certify that each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

Further consideration is respectfully solicited.

Respectfully submitted,

TFC/smd


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Encl: Copy of Japanese Office Action dated May 24, 2007
Form PTO-1449 and references cited thereon
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110.0703

INFORMATION
DISCLOSURE
CITATION

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U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	JP 2003-120653	04-23-2003	SUDO et al	Abstract
	AM	JP 2001-289238	10-19-2001	YAMADA et al	Abstract
	AN				
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.